ICTP-ITU-URSI School on Wireless Networking for Development The Abdus Salam International Centre for Theoretical Physics ICTP, Trieste (Italy), 6 to 24 February 2006

Signal Field-Strength Measurements: Basics

Ryszard Struzak

www.ryszard.struzak.com

Note: These are preliminary notes, intended only for distribution among the participants. Beware of misprints!

R Struzak

Purpose

- to refresh basic concepts related to measurements of physical quantities
 - Radio-wave field-strength
 - Antennas
 - Ect...

Topics for discussion

- Why measurements?
- What is error, uncertainty, accuracy?
- What factors do influence uncertainty?
- How to evaluate errors?
- What is least-square fitting?

- Measurement is essential in scientific research (except mathematics) and in engineering
- Usually, scientific/ engineering projects (calculations, models, reports,) must be supported by experimental evidence get through measurements to make them credible/ reliable
- Experiments/ measurements must be fully documented to make their reproduction possible

» Measurement protocols, photographs, etc

Measurements: legal aspects

Spectrum management applications (legal)

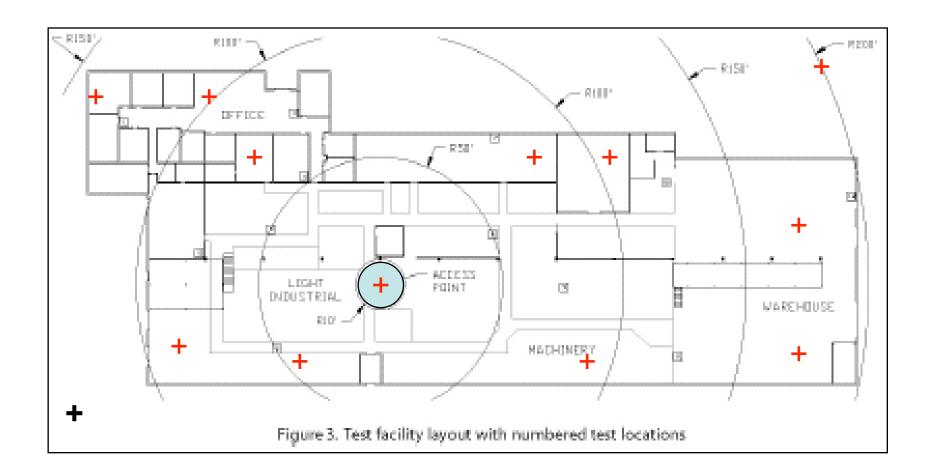
- Checking compliance with the regulations, licenses, and standards
- Radio Monitoring
- Checking channel occupancy
- Solving interference problems
- Absolute values required as evidence

Measurements: engineering

- Wanted signal
 - Will my system operate correctly?
 - Producing "local" propagation models for improved predictions (power budget)
 - Where should my antennas be located? On what height? (Optimizing station parameters)
 - Survey/ monitoring of local signal-environment selection the best channel
 - Does my system operate correctly?
 - Checking the antenna radiation pattern and/ or the station coverage area
 - Required signal intensity/ quality of service/ distance/ area/ volume?, given the geographic region and time period
- Unwanted signals
 - Could my system coexist with other systems? Will my system suffer unacceptable interference? Will it produce such interference to other systems? Degradation of service quality and/ or service range/ area due to potential radio interference?
- Relative values are often sufficient

- Legal measurements & Important projects
 - Measurement results must be accompanied by a formal statement of uncertainty (compliance tests)
 - Discrepancies should be clarified
- Comparative measurements
- Qualitative indicators

Indoor

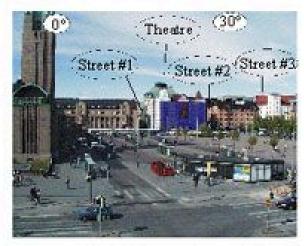


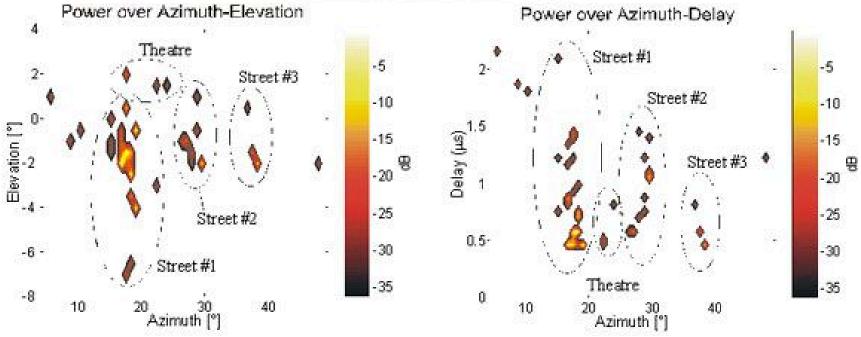


Outdoor 1

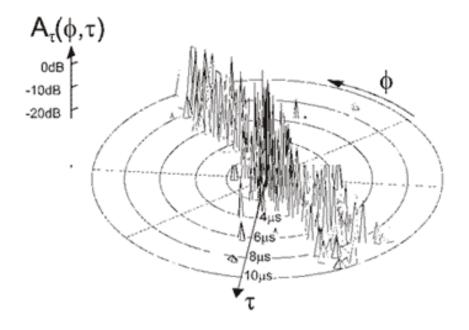
Revised ERC RECOMMENDATION (00)08 FIELD STRENGTH MEASUREMENTS ALONG A ROUTE WITH GEOGRAPHICAL COORDINATE REGISTRATIONS October 2003 http://www.ero.dk/documentation/ docs/doc98/official/pdf/ ERCREC0008.PDF







R Struzak

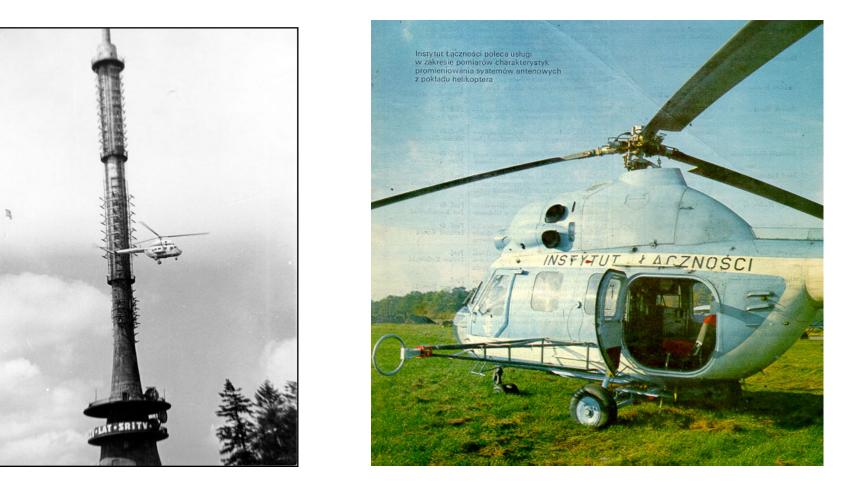


 Andreas F. Molisch, Alexander Kuchar, Juha Laurila, Martin Steinbauer, Martin Toeltsch, and Ernst Bonek: Spatial Channel Measurement and Modeling -<u>http://www.techonline.com/community/</u> <u>ed_resource/feature_article/14707</u>

Figure 1: The figure depicts the azimuth delay power spectrum for a mobile station in a street canyon. The radial axis represents the delay, where the origin

. . . .

Outdoor 2



Miniature models can be used

R Struzak

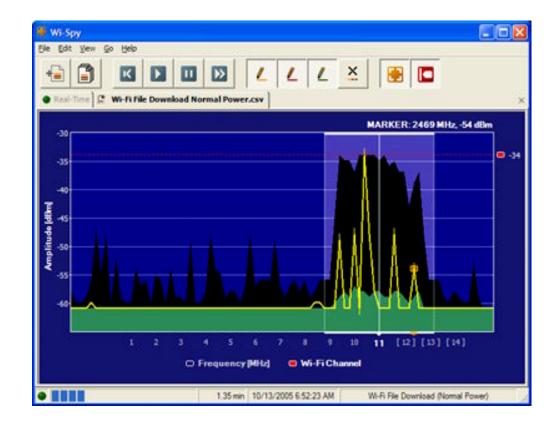
Spectrum analyzer



- Measures the signal field-strength, if equipped with an antenna
 - Absolute if calibrated, otherwise relative values

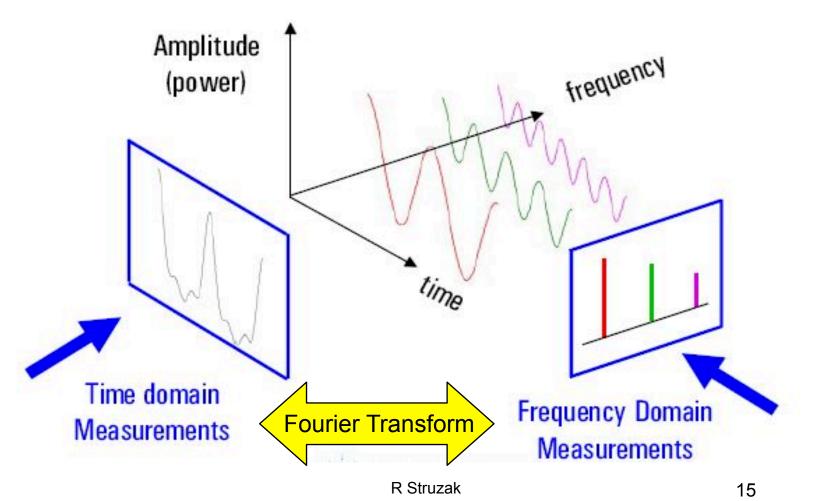
R Struzak





Frequency & time domains

•The signal received can be characterized in the **time domain or in** the **frequency** domain.



Types of spectrum analyzers

- Analogue or Swept-Spectrum
 - A tunable measuring receiver (analogue <u>band pass analogue</u> <u>filter</u>), whose midfrequency is automatically swept through the range of frequencies of interest
 - Usually offers only amplitude information in the frequency domain

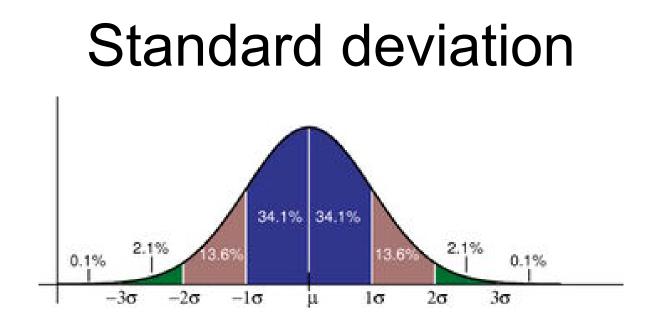
- Digital
 - A combination of a fast A/D converter and specialized computer that implements the <u>Fast Fourier Transform</u> (FFT)
 - Can offer amplitude and phase information in the frequency domain

What is error?

- An **error** is
 - a difference between a computed, estimated, or measured value and the true, specified, or theoretically correct value
 - a bound on the precision and accuracy of the result of a measurement
- Errors can be classified into two types: statistical and systematic.

Systematic vs. random errors

- Statistical (random) error
 - Unpredictable
 - Due to random causes (fluctuations)
 - Can be reduced by repeating measurements many times and their statistical analysis
- Systematic error
 - caused by a non-random influence
 - If the cause of the systematic error can be identified, then it can usually be eliminated.



Measurement results follow often the normal distribution: $f(x, \mu, \sigma) = \frac{1}{\sigma \sqrt{2\pi}} \exp\left(-\frac{(x-\mu)^2}{2\sigma^2}\right)$ Arithmetic mean is the expected (most probable) result: $\mu = \overline{x} = \frac{1}{n} \sum_{i=1}^{n} x_i$

The standard deviation σ_x is a measure of how widely the measured values are dispersed from their average value: $\sigma_x = \sqrt{\frac{1}{(n-1)}\sum_{i=1}^n (x_i - \overline{x})^2}$

Wikipedia

R Struzak

Uncertainty & accuracy

- Since the true value of measured quantity is unknown (the measured values are only its *estimates*), measurements are associated with <u>uncertainty</u>.
- The absolute uncertainty is an interval into which the true value falls with a given probability; it is expressed in the same unit as the measurement result.
- The relative uncertainty is the quotient of the absolute uncertainty and the best possible estimate of the true value.
- The lower the uncertainty the higher is the <u>accuracy</u> with which a measurement is made.

Confidence

Confidence interval (for a population mean) shows the interval within which the true mean value is

Conf. interval = 100 $(1-\alpha)\%$; e.g. $\alpha = 0.05$ indicates a 95% confidence level α = the significance level σ = standard deviation n = size of the sample = no. of measurements

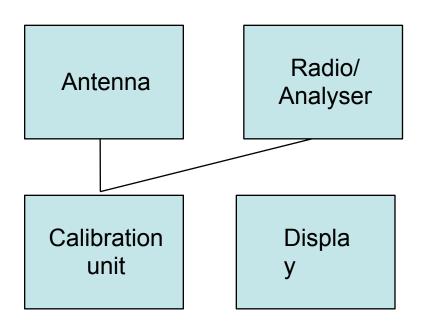
E.g. for $\alpha = 0.05$, we need to calculate the area under the standard normal curve that equals $(1-\alpha)$ or 95%. This value is ± 1.96 . The corresponding confidence interval is therefore $x \pm 1.96\sigma$

Factors influencing uncertainty

- Field strength & power flux density measurements at microwaves depend on local environment
 - Errors due to interfering & reflected signals
 - Simulation: <u>http://www.educatorscorner.com/index.cgi?</u>
 <u>CONTENT_ID=2490</u>
 - Reading errors
 - antenna calibration factor
 - attenuation of the connections between antenna and receiver
 - receiver sine-wave voltage accuracy

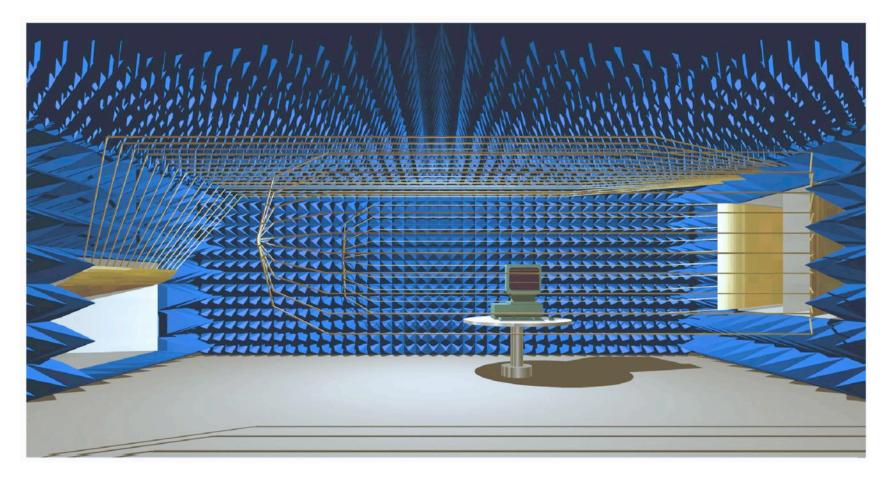
- shadowing due to obstacles
- device selectivity relative to occupied bandwidth
- device noise floor
- antenna factor frequency interpolation
- antenna factor variation with height above ground and other mutual coupling effects

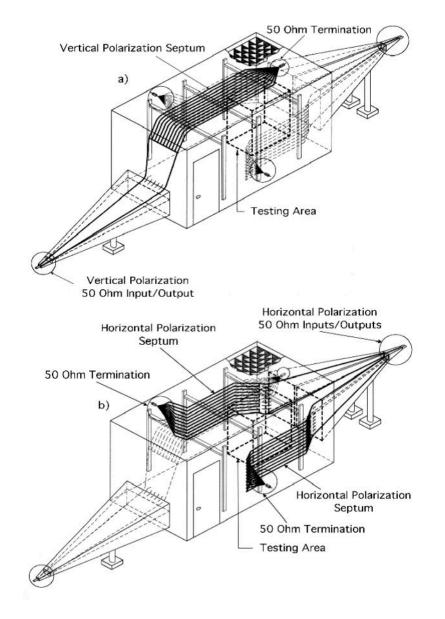
- Antenna impedance mismatch (between antenna port and the input)
- antenna balance mismatch
- antenna directivity mismatch
- antenna cross-polarisation response
- Errors due to spectrum analyzers:
 - Hewlett Packard: Spectrum Analysis Basics
 - Rauscher C: Fundamentals of Spectrum Analysis



- Calibration: setting the response of a measuring system within specified accuracy/ precision
- Traceability: relating an instrument's accuracy to the master reference standard s
 - <u>http://en.wikipedia.org/</u> wiki/Metrology

TEM cell

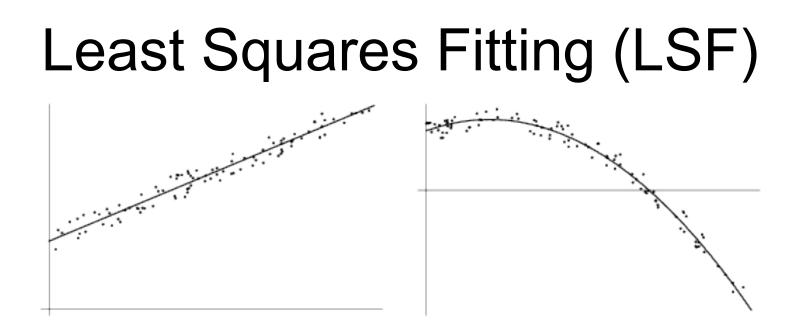




Field-strength (1 point in space)

- Simple simulation of the field-strength in a single point MeasurSimul1.xls

 Vienna agreement
- What with field-strength distence dependence (2 variables)?



- Most popular approach: statistical analysis under assumption that measurement errors are random (normally distributed)
- LSF = a mathematical procedure for finding the bestfitting curve to a given set of points
- Minimizing the sum of the squares of the offsets ("the residuals") of the points from the curve.

Linear least squares

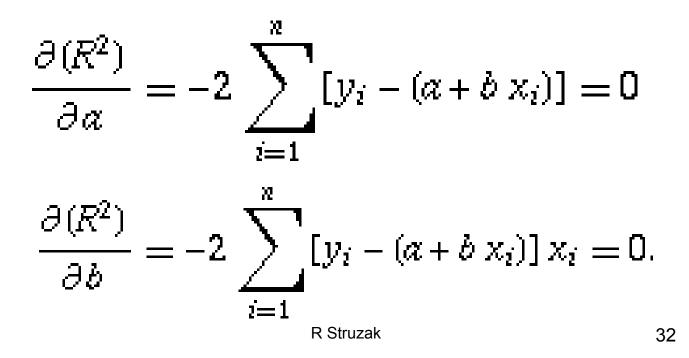
- Provides solution to the problem of finding the best fitting straight line through a set of points
 - The simplest and most commonly applied form of linear regression
- Applicable to linear models (and models that can be linearized)

Theoretical background

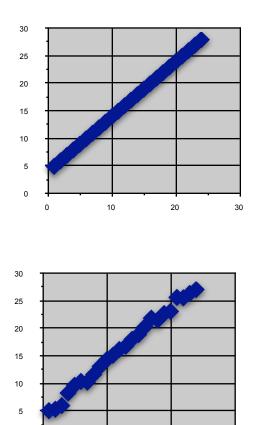
- Vertical least squares fitting proceeds by finding such a straight line y = a + bx that minimizes the sum of the squares of the vertical deviations of the data points (x_i, y_i)
- The square deviations from each point are summed, and the resulting residual (correlation factor) is then minimized to find the best-fit line.

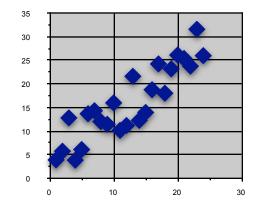
$$R^{2}(a,b,x_{i}) \equiv \sum_{i=1}^{n} \left[y_{i} - (a+bx_{i}) \right]^{2}$$

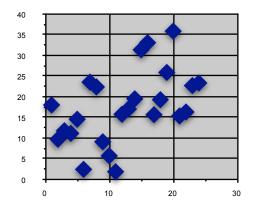
 The square deviations from each point are summed, and the resulting residual is then minimized to find the best fit line.

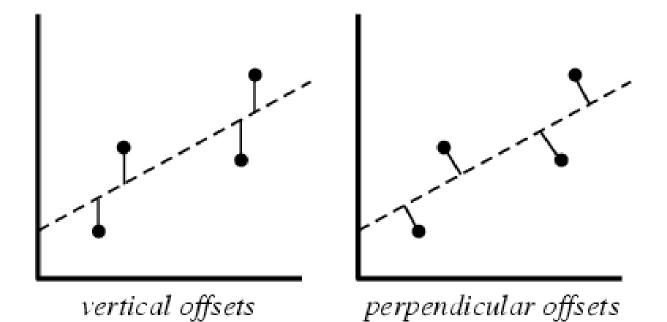


R² Interpretation









 For simplicity, the vertical offsets from a line (surface, etc.) are usually minimized instead of the perpendicular offsets

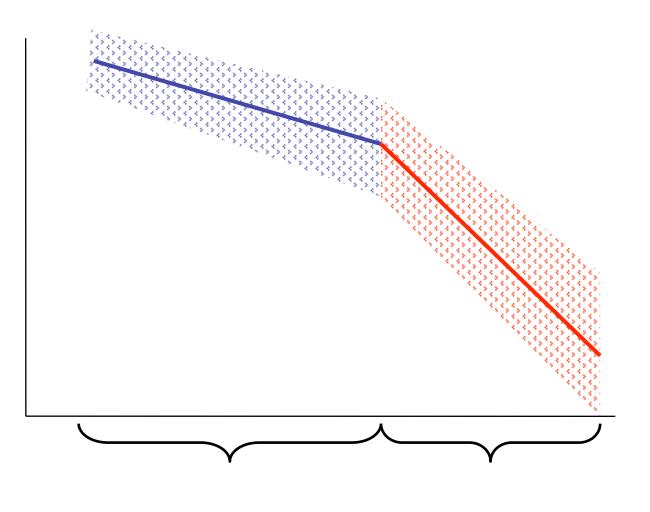
Least Squares Fitting--Perpendicular Offsets,

Example: Linear least squares

 Simple simulation of distance-dependence of the field-strength measurements: MeasurSimul2

What with non-linear?

- If the general form of the functional relationship between the two quantities being graphed is non-linear, we can apply
 - functional transformation of the variables in such a way that the resulting line *is* a straight line
 - Apply more complex fitting, e.g.
 - Least Squares Fitting--Exponential,
 - Least Squares Fitting--Logarithmic,
 - Least Squares Fitting--Polynomial,
 - Least Squares Fitting--Power Law,



Example: local propagation model

- Assume a simple propagation model of the form P = Cd⁻ⁿ where P is the signal power in W, d is distance in m, and C and n are constants to be determined from measurements
- We take logarithm (base 10): log(P[W]) = log(C) n*log(d[m])
- We substitute for new variables: y = log(P/1W); x = log(d/1m) and for new constants: a = log(C) and b = n
- The propagation model is linear in new variables: y = a + bx
- New constants a and b can be determined using the Linear Least Square Fit and then the original constants are determined
- Note: It means that the P-axis is *linear* if P is expressed in dBW, and the d-axis in [m] is *logarithmic*

Formulas

$$y = a + bx$$

$$b = \frac{SS_{xy}}{SS_{xx}}$$

$$a = \overline{y} - b\overline{x}$$

$$r^2 = \frac{SS_{xy}^2}{SS_{xx}SS_{yy}}$$

$$\overline{x} = \frac{1}{n} \sum_{i=1}^{n} x_i; \quad \overline{y} = \frac{1}{n} \sum_{i=1}^{n} y_i;$$

$$ss_{xx} = \left(\sum_{i=1}^{n} x_i^2\right) - n\left(\overline{x}\right)^2$$

$$ss_{yy} = \left(\sum_{i=1}^{n} y_i^2\right) - n\left(\overline{y}\right)^2$$

$$ss_{xy} = \left(\sum_{i=1}^{n} x_i y_i\right) - n\overline{xy}$$

$$s = \sqrt{\frac{ss_{yy} - \frac{ss_{xy}^2}{ss_{xx}}}{n-2}}$$

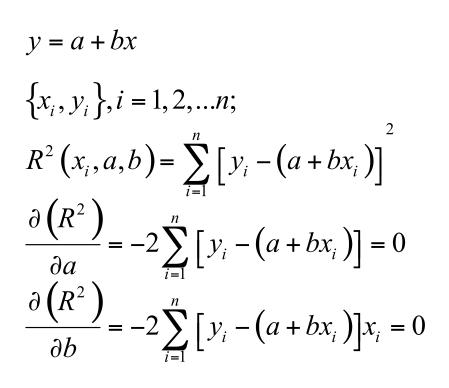
$$SE(a) = s\sqrt{\frac{1}{n} + \frac{\overline{x}}{ss_{xx}}}$$

$$SE(b) = \frac{s}{\sqrt{ss_{xx}}}$$

39

R Struzak

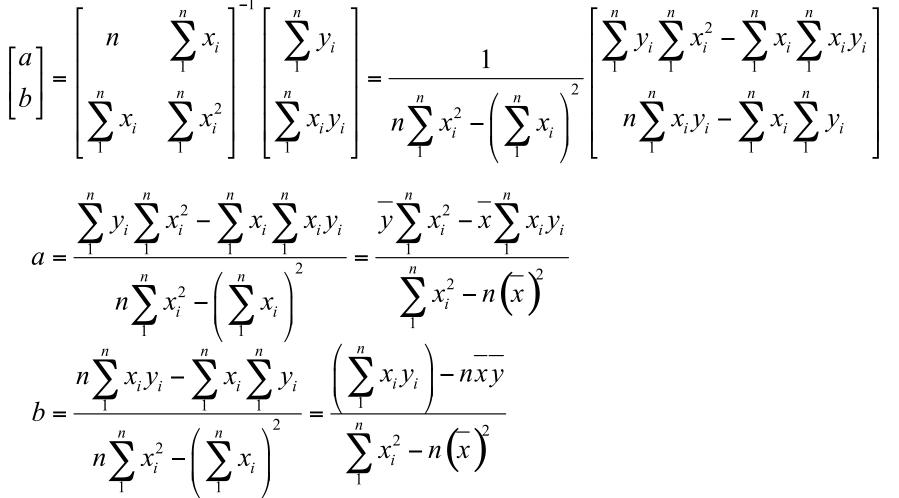
Mathematics of Linear least squares

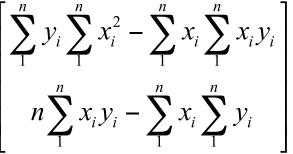


$$na + b\sum_{1}^{n} x_{i} = \sum_{1}^{n} y_{i}$$

$$a\sum_{1}^{n} x_{i} + b\sum_{1}^{n} x_{i}^{2} = \sum_{1}^{n} x_{i}y_{i}$$

$$\begin{bmatrix} n & \sum_{1}^{n} x_{i} \\ \sum_{1}^{n} x_{i} & \sum_{1}^{n} x_{i}^{2} \end{bmatrix} \begin{bmatrix} a \\ b \end{bmatrix} = \begin{bmatrix} \sum_{1}^{n} y_{i} \\ \sum_{1}^{n} x_{i}y_{i} \end{bmatrix}$$





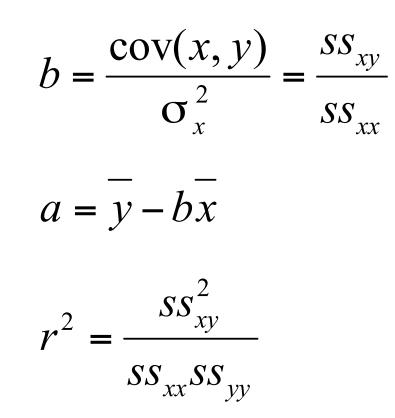
$$ss_{xx} = \sum_{i=1}^{n} \left(x_i - \overline{x} \right)^2 = \left(\sum_{i=1}^{n} x_i^2 \right) - n \left(\overline{x} \right)^2$$
$$ss_{yy} = \sum_{i=1}^{n} \left(y_i - \overline{y} \right)^2 = \left(\sum_{i=1}^{n} y_i^2 \right) - n \left(\overline{y} \right)^2$$

$$ss_{xy} = \sum_{i=1}^{n} \left(x_i - \overline{x} \right) \left(y_i - \overline{y} \right) = \left(\sum_{i=1}^{n} x_i y_i \right) - n\overline{xy}$$

$$\sigma_x^2 = \frac{ss_{xx}}{n}$$

$$\sigma_y^2 = \frac{ss_{yy}}{n}$$

$$\operatorname{cov}(x, y) = \frac{ss_{Xy}}{n}$$



 r2 is correlation coefficient that gives the proportion of ssyy which is accounted for by the regression Let yi* be the vertical coordinate of the best-fit line at coordinate xi, and ei be its distance to the actual measurement point yi. Then

 $e_i \equiv y_i - y_i^*$ $s^2 = \sum_{i=1}^n \frac{e_i^2}{n-2}$

 $y_i^* \equiv a + bx_i$

 $s = \sqrt{\frac{ss_{yy} - bss_{xy}}{n - 2}} = \sqrt{\frac{ss_{yy}^{2} - \frac{ss_{xy}^{2}}{ss_{xx}}}{n - 2}}$

$$SE(a) = s_{\sqrt{\frac{1}{n} + \frac{x^2}{ss_{xx}}}}$$

Standard errors

$$SE(b) = \frac{S}{\sqrt{SS_{xx}}}$$

Summary

- We have reviewed basic issues that should be taken into account when measuring the signal field strength
- There are numerous programs that facilitate the processing of measurement results
 - But they cannot be used blindly
 - They should be used with full understanding -they cannot replace common sense

References

- Alevy A M: In-Building Propagation Measurements at 2.4 GHz
- Taylor B N, Kuyatt C E: Guidelines for Evaluating and Expressing the Uncertainty of Measurement Results <u>http://physics.nist.gov/Pubs/guidelines/</u> <u>appa.html</u>
- Weisstein E W: "Least Squares Fitting." From <u>MathWorld</u>--A Wolfram Web Resource. <u>http://</u> <u>mathworld.wolfram.com/</u> <u>LeastSquaresFitting.html</u>
- Wysocki TA, Zepernick HJ: Characterization of the indoor radio propagation channel at 2.4 GHz; Journal of Telecommunications and Information Technology Nr. 3-4/2000, p. 84-90

Links

- <u>ANOVA</u>,
- <u>Correlation Coefficient,</u>
- Interpolation,
- <u>MANOVA</u>,
- Matrix 1-Inverse,
- <u>Moore-Penrose Matrix Inverse,</u>
- <u>Nonlinear Least Squares Fitting</u>,
- <u>Pseudoinverse</u>,
- <u>Regression Coefficient,</u>
- <u>Residual</u>,
- <u>Spline</u>.

Thank you